

# FCC Part 15 EMI TEST REPORT of

E.U.T. : Bluetooth Headset

MODEL : HBM-004

FCC ID. : QE5HBM004

for

APPLICANT : HIT Incorporated

ADDRESS : 4F, 8, Lane 235, Pao-Chiao Road, Shin Tien City,  
Taipei, Taiwan, R.O.C.

Test Performed by

**ELECTRONICS TESTING CENTER, TAIWAN**  
NO. 34, LIN 5, DING FU TSUN, LINKOU HSIANG,  
TAIPEI HSIEN, TAIWAN, R.O.C.

Tel:(02)26023052

Fax:(02)26010910

<http://www.etc.org.tw> ; e-mail:etcemi@ssed.net.tw

Report Number : ET91R-12-110-01

# TEST REPORT CERTIFICATION

Applicant : HIT Incorporated  
4F, 8, Lane 235, Pao-Chiao Road, Shin Tien City, Taipei, Taiwan,  
R.O.C.

Manufacturer : HIT Incorporated  
4F, 8, Lane 235, Pao-Chiao Road, Shin Tien City, Taipei, Taiwan,  
R.O.C.

Description of EUT :

- a) Type of EUT : Bluetooth Headset
- b) Trade Name : HIT Incorporated
- c) Model No. : HBM-004
- d) Power Supply : Input: 230Vac, 50Hz, 55mA; Output: 4.5Vdc, 300mA

Regulation Applied : FCC Rules and Regulations Part 15 Subpart B & C (2002)

I HEREBY CERTIFY THAT: The data shown in this report were made in accordance with the procedures given in ANSI C63.4, and the energy emitted by the device was founded to be within the limits applicable. I assume full responsibility for accuracy and completeness of these data.


Note: 1. The result of the testing report relates only to the item tested.

2. The testing report shall not be reproduced expect in full, without the written approval of ETC.

Issued Date : Jan. 21, 2003

Test Engineer :   
( Keven Lee )

Approve & Authorized Signer :

  
Will Yauo, Manager  
EMC Dept. II of ELECTRONICS  
TESTING CENTER, TAIWAN

<b>Table of Contents</b>	<b>Page</b>
<b>1 GENERAL INFORMATION .....</b>	<b>1</b>
1.1 Product Description.....	1
1.2 Characteristics of Device.....	1
1.3 Test Methodology .....	1
1.4 Test Facility.....	1
1.5 Modist List.....	1
<b>2 PROVISIONS APPLICABLE.....</b>	<b>2</b>
2.1 Definition.....	2
2.2 Requirement for Compliance.....	3
2.3 Restricted Bands of Operation.....	5
2.4 Labeling Requirement .....	5
2.5 User Information .....	6
<b>3. SYSTEM TEST CONFIGURATION .....</b>	<b>7</b>
3.1 Justification.....	7
3.2 Devices for Tested System .....	7
<b>4 RADIATED EMISSION MEASUREMENT.....</b>	<b>8</b>
4.1 Applicable Standard.....	8
4.2 Measurement Procedure.....	8
4.3 Measuring Instrument .....	10
4.4 Radiated Emission Data.....	11
4.4.1 Fundatmental and Harmonics.....	11
4.4.2 Other Emissions.....	14
4.5 Field Strength Calculation.....	15
4.6 Photos of Radiation Measuring Setup.....	16
<b>5 CONDUCTED EMISSION MEASUREMENT.....</b>	<b>17</b>
5.1 Standard Applicable .....	17
5.2 Measurement Procedure.....	17
5.3 Conducted Emission Data.....	18
5.4 Result Data Calculation.....	19
5.5 Conducted Measurement Equipment.....	19
5.6 Photos of Conduction Measuring Setup .....	20
<b>6 ANTENNA REQUIREMENT.....</b>	<b>21</b>
6.1 Standard Applicable .....	21
6.2 Antenna Connected Construction.....	21
<b>7 HOPPING CHANNEL SEPARATION .....</b>	<b>22</b>

7.1 Standard Applicable .....	22
7.2 Measurement Procedure.....	22
7.3 Measurement Equipment .....	22
7.4 Measurement Data .....	23
<b>8 NUMBER OF HOPPING FREQUENCY USED .....</b>	<b>24</b>
8.1 Standard Applicable .....	24
8.2 Measurement Procedure.....	24
8.3 Measurement Equipment .....	24
8.4 Measurement Data .....	25
<b>9 CHANNEL BANDWIDTH .....</b>	<b>26</b>
9.1 Standard Applicable .....	26
9.2 Measurement Procedure.....	26
9.3 Measurement Equipment .....	26
9.4 Measurement Data .....	27
<b>10 DWELL TIME ON EACH CHANNEL.....</b>	<b>28</b>
10.1 Standard Applicable .....	28
10.2 Measurement Procedure.....	28
10.3 Measurement Equipment .....	28
10.4 Measurement Data .....	29
<b>11 OUTPUT POWER MEASUREMENT.....</b>	<b>30</b>
11.1 Standard Applicable .....	30
11.2 Measurement Procedure.....	30
11.3 Measurement Equipment .....	30
11.4 Measurement Data .....	31
<b>12 100 kHz BANDWIDTH OF BAND EDGES MEASUREMENT.....</b>	<b>32</b>
12.1 Standard Applicable .....	32
12.2 Measurement Procedure.....	32
12.3 Measurement Equipment .....	32
12.4 Measurement Data .....	33
<b>APPENDIX 1 : PLOTTED DATA OF POWER LINE CONDUCTED EMISSIONS .....</b>	<b>34</b>
<b>APPENDIX 2 : PLOTTED DATA FOR SEPARATION OF ADJACENT CHANNEL.....</b>	<b>37</b>
<b>APPENDIX 3 : PLOTTED DATA FOR TOTAL USED HOPPING FREQUENCIES.....</b>	<b>41</b>
<b>APPENDIX 4 : PLOTTED DATA FOR CHANNEL BANDWIDTH.....</b>	<b>43</b>
<b>APPENDIX 5 : PLOTTED DATA FOR CHANNEL DWELL TIME.....</b>	<b>47</b>

<b>APPENDIX 6 : PLOTTED DATA FOR OUTPUT PEAK POWER.....</b>	<b>54</b>
<b>APPENDIX 7 : PLOTTED DATA FOR 100 KHZ BANDWIDTH FROM BAND EDGE.....</b>	<b>58</b>

# 1 GENERAL INFORMATION

## 1.1 Product Description

- a) Type of EUT : Bluetooth Headset
- b) Trade Name : HIT Incorporated
- c) Model No. : HBM-004
- d) Power Supply : Input: 230Vac, 50Hz, 55mA; Output: 4.5Vdc, 300mA

## 1.2 Characteristics of Device

The Wireless Headset is using standard Bluetooth technology. It is compatible with any Bluetooth enable audio gateway device. It's unique state of the art design and user friendly interface can bring the most convenient way of life.

## 1.3 Test Methodology

For Bluetooth Headset, both conducted and radiated emissions were performed according to the procedures illustrated in ANSI C63.4 (1992) and for processing gain measurement is according to FCC Public Notice. Other required measurements were illustrated in separate sections of this test report for details.

## 1.4 Test Facility

The open area test site and conducted measurement facility used to collect the radiated data is located on the roof top of Building at No.34, Lin 5, Ding Fu Tsun, Linkou Hsiang, Taipei Hsien, Taiwan, R.O.C.

This site has been fully described in a report submitted to your office, and accepted in a letter dated Feb. 10, 2000.

## 1.5 Modist List

There are two conductive copper tapes assembly between the metal card frame and the internal shielded cam (see the assembly part picture).

## 2 PROVISIONS APPLICABLE

### 2.1 Definition

**Unintentional radiator:**

A device that intentionally generates and radio frequency energy for use within the device, or that sends radio frequency signals by conduction to associated equipment via connecting wiring, but which is not intended to emit RF energy by radiation or induction.

**Class A Digital Device:**

A digital device which is marketed for use in commercial or business environment; exclusive of a device which is market for use by the general public, or which is intended to be used in the home.

**Class B Digital Device :**

A digital device which is marketed for use in a residential environment notwithstanding use in a commercial, business of industrial environment. Example of such devices that are marketed for the general public.

Note : A manufacturer may also qualify a device intended to be marketed in a commercial, business, or industrial environment as a Class B digital device, and in fact is encouraged to do so, provided the device complies with the technical specifications for a Class B Digital Device. In the event that a particular type of device has been found to repeatedly cause harmful interference to radio communications, the Commission may classify such a digital device as a Class B Digital Device, Regardless of its intended use.

**Intentional radiator:**

A device that intentionally generates and emits radio frequency energy by radiation or induction.

## 2.2 Requirement for Compliance

### (1) Conducted Emission Requirement

Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150kHz to 30 MHz shall not exceed the limits in the following table, as measured using a 50 $\Omega$  H/50 ohms line impedance stabilization network (LISN). Compliance with the provisions of this paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower limit applies at the boundary between the frequency ranges.

Frequency MHz	Quasi Peak dB $\mu$ V	Average dB $\mu$ V
0.15 - 0.5	66-56*	56-46*
0.5 - 5.0	56	46
5.0 - 30.0	60	50

\* Decreases with the logarithm of the frequency

For intentional device, according to § 15.207(a) Line Conducted Emission Limits is same as above table.

### (2) Radiated Emission Requirement

For unintentional device, according to § 15.109(a), except for Class A digital devices, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency MHz	Distance Meters	Radiated dB $\mu$ V/m	Radiated $\mu$ V/m
30 - 88	3	40.0	100
88 - 216	3	43.5	150
216 - 960	3	46.0	200
Above 960	3	54.0	500

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the above table.



**(3) Antenna Requirement**

For intentional device, according to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

**(4) Hopping Channel Separation**

According to 15.247(a)(1), frequency hopping system shall have , hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

**(5) Number of Hopping frequencies used**

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands shall use at least 75 hopping frequencies.

**(6) Hopping Channel Bandwidth**

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands, the maximum 20 dB bandwidth of the hopping channel is 1MHz.

**(7) Dwell Time of each frequency within a 30-second period**

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands, the average time of occupancy on any frequency shall not be greater than 0.4 second within a 30-second period.

**(8) Output Power Requirement**

For direct sequence system, according to 15.247(b), the maximum peak output power of the transmitter shall not exceed 1 Watt. If transmitting antennas of directional gain greater than 6 dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

**(9) 100 kHz Bandwidth of Frequency Band Edges Requirement**

According to 15.247(c), if any 100 kHz bandwidth outside these frequency bands, the radio frequency power that is produced by the modulation products of the spreading sequence, the information sequence and the carrier frequency shall be either at least 20 dB below that in any 100 kHz bandwidth within the band that contains the highest level of the desired power or shall not exceed the general levels specified in § 15.209(a), whichever results in the lesser attenuation.

## 2.3 Restricted Bands of Operation

Only spurious emissions are permitted in any of the frequency bands listed below :

MHz	MHz	MHz	GHz
0.090 - 0.110	16.42-16.423	399.9-410	4.5-5.25
0.495 - 0.505 **	16.69475 - 16.69525	608-614	5.35-5.46
2.1735 - 2.1905	16.80425 - 16.80475	960-1240	7.25-7.75
4.125-4.128	25.5-25.67	1300-1427	8.025-8.5
4.17725-4.17775	37.5-38.25	1435-1626.5	9.0-9.2
4.20725-4.20775	73-74.6	1645.5-1646.5	9.3-9.5
6.215-6.218	74.8-75.2	1660-1710	10.6-12.7
6.26775-6.26825	108-121.94	1718.8-1722.2	13.25-13.4
6.31175-6.31225	123-138	2200-2300	14.47-14.5
8.291-8.294	149.9-150.05	2310-2390	15.35-16.2
8.362-8.366	156.52475 - 156.52525	2483.5-2500	17.7-21.4
8.37625-8.38675	156.7-156.9	2655-2900	22.01-23.12
8.41425-8.41475	162.0125-167.17	3260-3267	23.6-24.0
12.29-12.293	167.72-173.2	3332-3339	31.2-31.8
12.51975-12.52025	240-285	3345.8-3358	36.43-36.5
12.57675-12.57725	322-335.4	3360-4400	Above 38.6
13.36-13.41			

\*\* : Until February 1, 1999, this restricted band shall be 0.490-0.510 MHz

## 2.4 Labeling Requirement

The device shall bear the following statement in a conspicuous location on the device :

This device complies with part 15 of the FCC Rules. Operation is subject to the following two conditions : (1) This device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.

## 2.5 User Information

The users manual or instruction manual for an intentional or unintentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

For a Class B digital device or peripheral, the instructions furnished the user shall include the following or similar statement, placed in a prominent location in the text of the manual.

The Federal Communications Commission Radio Frequency Interference Statement includes the following paragraph.

This equipment has been tested and found to comply with the limits for a Class B Digital Device, pursuant to Part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference in a residential installation.

This equipment generates, uses and can radiate radio frequency energy and, if not installed and used in accordance with the instruction may cause harmful interference to radio communication. However, there is no guarantee that interference will not occur in a particular installation.

If this equipment does cause harmful interference to radio or television reception, which can be determined by turning the equipment off and on, the user is encouraged to try to correct the interference by one or more of the following measures:

- Reorient or relocate the receiving antenna.
- Increase the separation between the equipment and receiver.
- Connect the equipment into an outlet on a circuit different from that to which the receiver is connected.
- Consult the dealer or an experienced radio / TV technician for help.

### 3. SYSTEM TEST CONFIGURATION

#### 3.1 Justification

For both radiated and conducted emissions below 1 GHz, the system was configured for testing in a typical fashion as a customer would normally use it. The peripherals other than EUT were connected in normally standing by situation. Measurement was performed under the condition that a computer program was exercised to simulate data communication of EUT, and the transmission rate was set to maximum allowed by EUT. Three highest emissions were verified with varying placement of the transmitting antenna connected to EUT to maximize the emission from EUT.

For conducted emissions, only measured on TX and RX operation, for the digital circuits portion also function normally whenever TX or RX is operated. For radiated emissions, whichever RF channel is operated, the digital circuits' function identically. As the reason, measurement of radiated emissions from digital circuits is only performed with channel 11 by transmitting mode.

#### 3.2 Devices for Tested System

Device	Manufacture	Model / FCC ID.	Cable Description
Bluetooth Headset *	HIT Incorporated	HBM-004 QE5HBM004	1.2m Unshielded Cable

Remark “\*” means equipment under test.

## 4 RADIATED EMISSION MEASUREMENT

### 4.1 Applicable Standard

For unintentional radiator, the radiated emission shall comply with § 15.109(a).

For intentional radiators, according to § 15.247 (a), operation under this provision is limited to frequency hopping and direct sequence spread spectrum, and the out band emission shall be comply with § 15.247 (c)

### 4.2 Measurement Procedure

#### A. Preliminary Measurement For Portable Devices

For portable devices, the following procedure was performed to determine the maximum emission axis of EUT:

1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

#### B. Final Measurement

1. Setup the configuration per figure 5 and 6 for frequencies measured below and above 1 GHz respectively.
2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
3. For emission frequencies measured below and above 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.
4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0° to 360° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading. A RF test receiver is also used to confirm emissions measured.

Note : A high pass filter was used to avoid pre-amplifier saturated when measure TX operation mode in frequency band above 1 GHz.

5. Repeat step 4 until all frequencies need to be measured were complete.
6. Repeat step 5 with search antenna in vertical polarized orientations.
7. Check the three frequencies of highest emission with varying the placement of cables associated with EUT to obtain the worse case and record the result.

Figure 1 : Frequencies measured below 1 GHz configuration

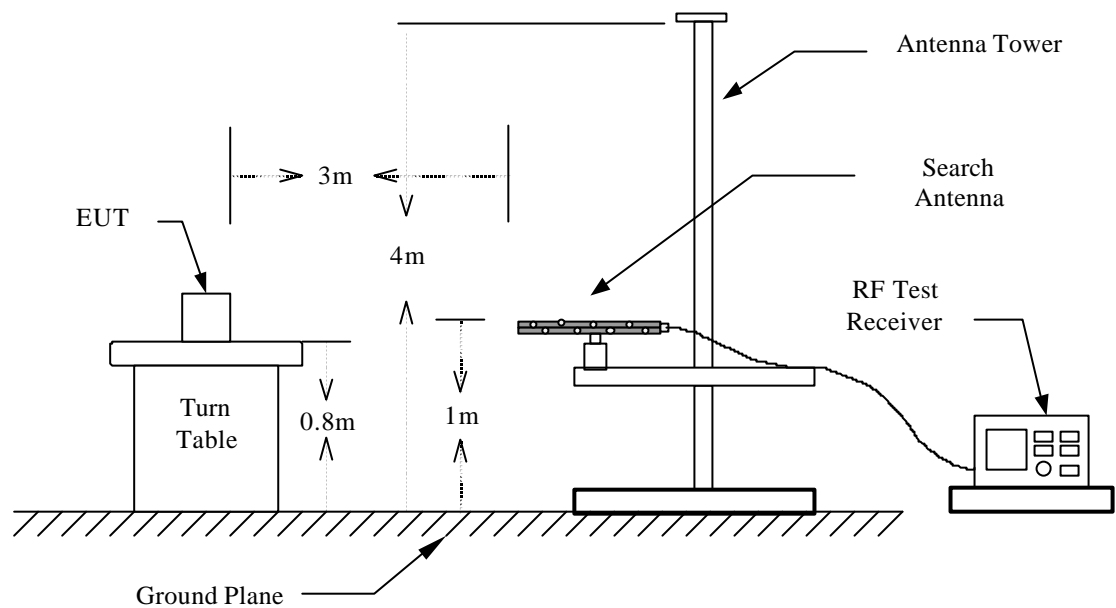
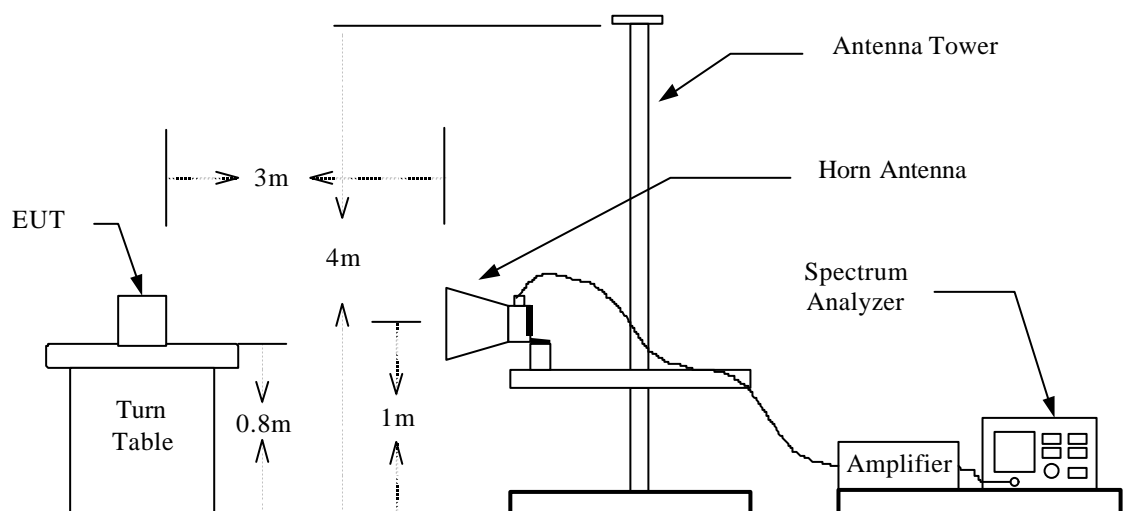


Figure 2 : Frequencies measured above 1 GHz configuration



### 4.3 Measuring Instrument

The following instrument are used for radiated emissions measurement:

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8568B	01/10/2003
Pre-selector	Hewlett-Packard	85685A	01/10/2003
Quasi Peak Detector	Hewlett-Packard	85650A	01/10/2003
RF Test Receiver	Rohde & Schwarz	ESVS 30	08/06/2003
RF Test Receiver	Rohde & Schwarz	ESBI	05/15/2003
Horn Antenna	EMCO	3115	05/15/2003
Log periodic Antenna	EMCO	3146	11/04/2003
Biconical Antenna	EMCO	3110B	11/04/2003
Preamplifier	Hewlett-Packard	8449B	05/29/2003
Preamplifier	Hewlett-Packard	8447D	09/29/2003
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003

Measuring instrument setup in measured frequency band when specified detector function is used :

Frequency Band (MHz)	Instrument	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	RF Test Receiver	Quasi-Peak	120 kHz	N/A
	Spectrum Analyzer	Peak	100 kHz	100 kHz
Above 1000	Spectrum Analyzer	Peak	1 MHz	1 MHz
	Spectrum Analyzer	Average	1 MHz	300 Hz

## 4.4 Radiated Emission Data

### 4.4.1 Fundatmental and Harmonics

Operation Mode : TX/RX

Fundamental Frequency : 2402 MHz

Test Date : Dec. 30, 2002

Temperature : 18

Humidity : 65 %

Frequency (MHz)	Reading (dBuV)				Factor (dB) Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H Peak	V Ave	H Peak	V Ave		Peak	Ave	Peak	Ave.			
*2400.023	---	---	---	---	-3.1	---	---	74.0	54.0	---	---	---
*4800.046	---	---	---	---	2.5	---	---	74.0	54.0	---	---	---
*7200.069	---	---	---	---	5.7	---	---	74.0	54.0	---	---	---
*9600.092	---	---	---	---	7.2	---	---	74.0	54.0	---	---	---
*12000.115	---	---	---	---	9.2	---	---	74.0	54.0	---	---	---
4804.034	---	---	---	---	2.5	---	---	74.0	54.0	---	---	---
7206.051	---	---	---	---	5.7	---	---	74.0	54.0	---	---	---
9608.068	---	---	---	---	7.2	---	---	74.0	54.0	---	---	---
12010.085	---	---	---	---	9.2	---	---	74.0	54.0	---	---	---
14412.102	---	---	---	---	11.5	---	---	74.0	54.0	---	---	---

Note :

1. Remark “\*” means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark “---” means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.



Operation Mode : TX/RX

Fundamental Frequency : 2441 MHz

Test Date : Dec. 30, 2002

Temperature : 18

Humidity : 65 %

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
*2439.056	---	---	---	---	-2.9	---	---	74.0	54.0	---	---	---
*4878.112	---	---	---	---	2.7	---	---	74.0	54.0	---	---	---
*7317.168	---	---	---	---	5.9	---	---	74.0	54.0	---	---	---
*9756.224	---	---	---	---	7.3	---	---	74.0	54.0	---	---	---
*12195.280	---	---	---	---	9.3	---	---	74.0	54.0	---	---	---
4882.166	---	---	---	---	2.7	---	---	74.0	54.0	---	---	---
7323.249	---	---	---	---	5.9	---	---	74.0	54.0	---	---	---
9764.332	---	---	---	---	7.3	---	---	74.0	54.0	---	---	---
12205.415	---	---	---	---	9.3	---	---	74.0	54.0	---	---	---
14646.498	---	---	---	---	11.6	---	---	74.0	54.0	---	---	---

Note :

1. Remark "\*" means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark "---" means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

Operation Mode : TX/RX

Fundamental Frequency : 2480 MHz

Test Date : Dec. 30, 2002

Temperature : 18

Humidity : 65 %

Frequency  (MHz)	Reading (dBuV)				Factor (dB)  Corr.	Result @3m (dBuV/m)		Limit @3m (dBuV/m)		Margin (dB)	Table Deg. (Deg.)	Ant. High (m)
	H		V			Peak	Ave	Peak	Ave.			
	Peak	Ave	Peak	Ave								
2478.083	---	---	---	---	-2.8	---	---	74.0	54.0	---	---	---
4956.166	---	---	---	---	2.8	---	---	74.0	54.0	---	---	---
7434.249	---	---	---	---	6.1	---	---	74.0	54.0	---	---	---
9912.332	---	---	---	---	7.4	---	---	74.0	54.0	---	---	---
12390.415	---	---	---	---	9.4	---	---	74.0	54.0	---	---	---
4960.066	---	---	---	---	2.8	---	---	74.0	54.0	---	---	---
7440.099	---	---	---	---	6.1	---	---	74.0	54.0	---	---	---
9920.132	---	---	---	---	7.4	---	---	74.0	54.0	---	---	---
12400.165	---	---	---	---	9.4	---	---	74.0	54.0	---	---	---
14880.198	---	---	---	---	11.5	---	---	74.0	54.0	---	---	---

Note :

1. Remark “\*” means local oscillation frequency.
2. The receiving local oscillation frequency and the harmonics are too low to be measured.
3. Remark “---” means that the emission level is too low to be measured (a pre-amplifier of about 35 dB is used).
4. Margins are derived from Peak or Average whichever is lower. If there is only peak value in Result field, the Margin is also referred to average limits.
5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

**4.4.2 Other Emissions**

A.

Operation Mode : TX/RX

Test Date : Dec. 30, 2002

Temperature : 18

Humidity : 65 %

Frequency (MHz)	Ant-Pol H/V	Meter Reading (dBuV)	Corrected Factor (dB)	Result @3m (dBuV/m)	Limit @3m (dBuV/m)	Margin (dB)	Table Degree (Deg.)	Ant. High (m)
48.011	V	48.4	-13.6	34.8	40.0	-5.2	32	1.5
71.991	V	46.2	-16.2	30.0	40.0	-10.0	25	1.0
98.989	H	45.3	-13.9	31.4	43.5	-12.1	101	2.0
239.994	H	45.5	-4.5	41.0	46.0	-5.0	190	2.0
287.999	H	46.2	-2.1	44.1	46.0	-1.9	270	4.0
480.000	H	47.5	-4.5	43.0	46.0	-3.0	132	4.0
527.994	H	43.3	-5.0	38.3	46.0	-7.7	342	4.0

B.

Operation Mode : Charge &amp; Work

Test Date : Dec. 30, 2002

Temperature : 18

Humidity : 65 %

Frequency (MHz)	Ant-Pol H/V	Meter Reading (dBuV)	Corrected Factor (dB)	Result @3m (dBuV/m)	Limit @3m (dBuV/m)	Margin (dB)	Table Degree (Deg.)	Ant. High (m)
102.090	H	43.4	-13.4	30.0	43.5	-13.5	25	4.0
142.590	V	38.2	-10.6	27.6	43.5	-15.9	36	1.0
154.470	V	40.8	-9.8	31.0	43.5	-22.5	180	1.0
930.700	V	34.5	2.7	37.2	46.0	-8.8	175	1.0
951.700	V	34.3	3.3	37.6	46.0	-8.4	273	1.0
974.800	V	34.3	3.3	37.6	54.0	-16.4	152	1.5

Note :

1. Remark "---" means that the emissions level is too low to be measured.
2. The expanded uncertainty of the radiated emission tests is 3.53 dB.

c) Emission frequencies above 1 GHz

Radiated emission frequencies above 1 GHz to 5 GHz were too low to be measured with a pre-amplifier of 35 dB.

## 4.5 Field Strength Calculation

The field strength is calculated by adding the Antenna Factor, High Pass Filter Loss (if used) and Cable Loss, and subtracting the Amplifier Gain (if any) from the measured reading. The basic equation calculation is as follows:

$$\textbf{Result} = \textbf{Reading} + \textbf{Corrected Factor}$$

where

$$\text{Corrected Factor} = \text{Antenna FACTOR} + \text{Cable Loss} + \text{High Pass Filter Loss} - \text{Amplifier Gain}$$

## **4.6 Photos of Radiation Measuring Setup**

**Please See Setup Photos in Exhibit-F**

## 5 CONDUCTED EMISSION MEASUREMENT

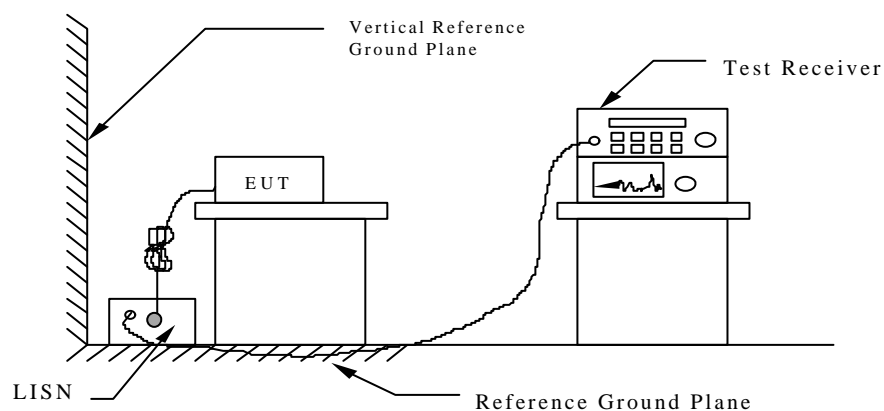
### 5.1 Standard Applicable

For unintentional and intentional device, Line Conducted Emission Limits are in accordance to § 15.107(a) and § 15.207(a) respectively.

### 5.2 Measurement Procedure

1. Setup the configuration per figure 3.
2. A preliminary scan with a spectrum monitor is performed to identify the frequency of emission that has the highest amplitude relative to the limit by operating the EUT in selected modes of operation, typical cable positions, and with a typical system configuration.
3. Record the 6 or 8 highest emissions relative to the limit.
4. Measure each frequency obtained from step 3 by a test receiver set on quasi peak detector function, and then record the accuracy frequency and emission level. If all emissions measured in the specified band are attenuated more than 20 dB from the limit, this step would be ignored, and the peak detector function would be used.
5. Confirm the highest three emissions with variation of the EUT cable configuration and record the final data.
6. Repeat all above procedures on measuring each operation mode of EUT.

Figure 3 : Conducted emissions measurement configuration



**5.3 Conducted Emission Data****A.**

Operation Mode : Charge &amp; Work

Test Date : Dec. 30, 2002

Temperature : 18

Humidity: 65 %

Freq.  (MHz)	Meter Reading (dB μ V)				Factor  (dB)	Limit (dB μ V)		Result (dB μ V)			
	Q.P Value		AVG. Value			Q.P Value	AVG. Value	Q.P Value		AVG. Value	
	N	L1	N	L1				N	L1	N	L1
0.157	15.0	13.8	----	----	0.2	65.6	55.6	15.2	14.0	----	----
0.247	11.6	10.9	----	----	0.2	61.9	51.9	11.8	11.1	----	----
0.353	10.6	10.4	----	----	0.3	58.9	48.9	10.9	10.7	----	----
0.875	19.3	17.6	----	----	0.3	56.0	46.0	19.6	17.9	----	----
2.035	10.9	10.7	----	----	0.5	56.0	46.0	11.4	11.2	----	----
24.000	35.8	34.6	----	----	1.5	60.0	50.0	37.3	36.1	----	----

*Note : 1. Please see appendix I for Plotted Data**2. The expanded uncertainty of the conducted emission tests is 2.45 dB.*

## 5.4 Result Data Calculation

The result data is calculated by adding the Factor (including LISN insertion loss and cable loss) to the measured reading. The basic equation with a sample calculation is as follows:

$$RESULT = READING + FACTOR$$

## 5.5 Conducted Measurement Equipment

The following test equipment are used during the conducted test.

Equipment	Manufacturer	Model No.	Next Cal. Due
EMI Test Receiver	Rohde and Schwarz	ESCS 30	11/15/2003
Line Impedance Stabilization network	Kyoritsu	KNW-407	12/02/2003
Plotter	Hewlett-Packard	7440A	N/A
Shielded Room	Riken		N.C.R.



## **5.6 Photos of Conduction Measuring Setup**

**Please See Setup Photos in Exhibit-F**

## **6 ANTENNA REQUIREMENT**

### **6.1 Standard Applicable**

For intentional device, according to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. And according to § 15.247 (b), if transmitting antennas of directional gain greater than 6 dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

### **6.2 Antenna Connected Construction**

The antenna terminal of this unit is designed to be mounted permanently on the device. Please see construction Photos Of Exhibit B for details.

## 7 HOPPING CHANNEL SEPARATION

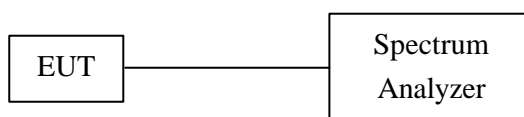
### 7.1 Standard Applicable

According to 15.247(a)(1), frequency hopping system shall have, hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

### 7.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
3. By using the MaxHold function record the separation of two adjacent channels.
4. Measure the frequency difference of these two adjacent channels by SA MARK function. And then plot the result on SA screen.
5. Repeat above procedures until all frequencies measured were complete.

Figure 4 : Emission bandwidth measurement configuration.



### 7.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Plotter	Hewlett-Packard	7440A	N/A

## 7.4 Measurement Data

Test Date : Dec. 30, 2002      Temperature : 18      Humidity: 65 %

- 1) 2402 MHz : Adjacent Hopping Channel Separation is 1000kHz
- 2) 2441 MHz : Adjacent Hopping Channel Separation is 1000kHz
- 3) 2480 Mhz : Adjacent Hopping Channel Separation is 1000kHz

***Note : 1. Please see appendix 2 for Plotted Data***

***2. The expanded uncertainty of the hopping channel separation tests is 2dB.***

## 8 NUMBER OF HOPPING FREQUENCY USED

### 8.1 Standard Applicable

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands shall use at least 75 hopping frequencies.

### 8.2 Measurement Procedure

1. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Set the SA on MaxHold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
4. Set the SA on View mode and then plot the result on SA screen.
5. Repeat above procedures until all frequencies measured were complete.

### 8.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Attenuator	Weinschel Engineering	1	N/A

## 8.4 Measurement Data

Test Date : Dec. . 30, 2002      Temperature : 18      Humidity: 65 %

There are 79 hopping frequencies in a hopping sequence.

***Note : 1. Please see appendix 3 for Plotted Data***

***2. The expanded uncertainty of umber of hopping frequency used tests is 2dB.***

## 9 CHANNEL BANDWIDTH

### 9.1 Standard Applicable

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands, the maximum 20dB bandwidth of the hopping channel is 1MHz.

### 9.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

### 9.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Attenuator	Weinschel Engineering	1	N/A

## 9.4 Measurement Data

Test Date : Dec. 30, 2002      Temperature : 18      Humidity: 65 %

- 1) 2402 MHz : Channel Bandwidth is 288 kHz
- 2) 2441 MHz : Channel Bandwidth is 277 kHz
- 3) 2480 MHz : Channel Bandwidth is 277 kHz

***Note : 1. Please see appendix 4 for Plotted Data***

***2. The expanded uncertainty of channel bandwidth tests is 2dB.***



## 10 DWELL TIME ON EACH CHANNEL

### 10.1 Standard Applicable

According to 15.247(a)(1)(ii), for frequency hopping system operating in the 2400-2483.5 MHz and 5725-5850 MHz bands, the average time of occupancy on any frequency shall not be greater than 0.4 second within a 30-second period.

### 10.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
4. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
5. Repeat above procedures until all frequencies measured were complete.

### 10.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Attenuator	Weinschel Engineering	1	N/A

## 10.4 Measurement Data

Test Date : Dec. 30, 2002      Temperature : 18      Humidity: 65 %

- 1) 2402 MHz : the dwell time is  $750 \mu s \times 89 \times 3 = 200.25 \text{ ms}$
- 2) 2441 MHz : the dwell time is  $750 \mu s \times 89 \times 3 = 200.25 \text{ ms}$
- 3) 2480 MHz : the dwell time is  $750 \mu s \times 89 \times 3 = 200.25 \text{ ms}$

The maximum time of occupancy for a particular channel is 249.9 msec in any 30 second period, which is less than the 400 msec allowed by the rules; therefore, it meets the requirements of this section.

***Note : 1. Please see appendix 5 for Plotted Data***

***2. The expanded uncertainty of dwell time on each channel tests is 2dB.***

## 11 OUTPUT POWER MEASUREMENT

### 11.1 Standard Applicable

For direct sequence system, according to 15.247(b), the maximum peak output power of the transmitter shall not exceed 1 Watt. If transmitting antennas of directional gain greater than 6 dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

### 11.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Set RBW of spectrum analyzer to 1 MHz and VBW to 1 MHz.
4. Measure the highest amplitude appearing on spectral display and record the level to calculate result data.
5. Repeat above procedures until all frequencies measured were complete.

### 11.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Attenuator	Weinschel Engineering	1	N/A

## 11.4 Measurement Data

Test Date : Dec. 30, 2002      Temperature : 18      Humidity: 65 %

- 1) 2402 MHz : Output Peak Power is  $-0.17 \text{ dBm} = 0.960 \text{ mW}$
- 2) 2441 MHz : Output Peak Power is  $-0.33 \text{ dBm} = 0.926 \text{ mW}$
- 3) 2480 MHz : Output Peak Power is  $-2.00 \text{ dBm} = 0.630 \text{ mW}$

***Note : 1. Please see appendix 6 for Plotted Data***

***2. The expanded uncertainty of output power measurement tests is 2dB.***

## 12 100 kHz BANDWIDTH OF BAND EDGES MEASUREMENT

### 12.1 Standard Applicable

According to 15.247(c), if any 100 kHz bandwidth outside these frequency bands, the radio frequency power that is produced by the modulation products of the spreading sequence, the information sequence and the carrier frequency shall be either at least 20 dB below that in any 100 kHz bandwidth within the band that contains the highest level of the desired power or shall not exceed the general levels specified in § 15.209(a), whichever results in the lesser attenuation.

### 12.2 Measurement Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in figure 4 without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
3. Set both RBW and VBW of spectrum analyzer to 300 kHz with a convenient frequency span including 100kHz bandwidth from band edge.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

### 12.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Hewlett-Packard	8564E	04/14/2003
Plotter	Hewlett-Packard	7440A	N/A

## 12.4 Measurement Data

Test Date : Dec. 30, 2002      Temperature : 18      Humidity: 65 %

- a) Lower Band Edge : All emissions in this 100kHz bandwidth are attenuated more than 20dB from the carrier.
- b) Upper Band Edge : All emissions in this 100kHz bandwidth are attenuated more than 20dB from the carrier.

***Note : 1. Please see appendix 7 for Plotted Data***

***2. The expanded uncertainty of the 100 KHz bandwidth of band edges tests is 1000Hz.***

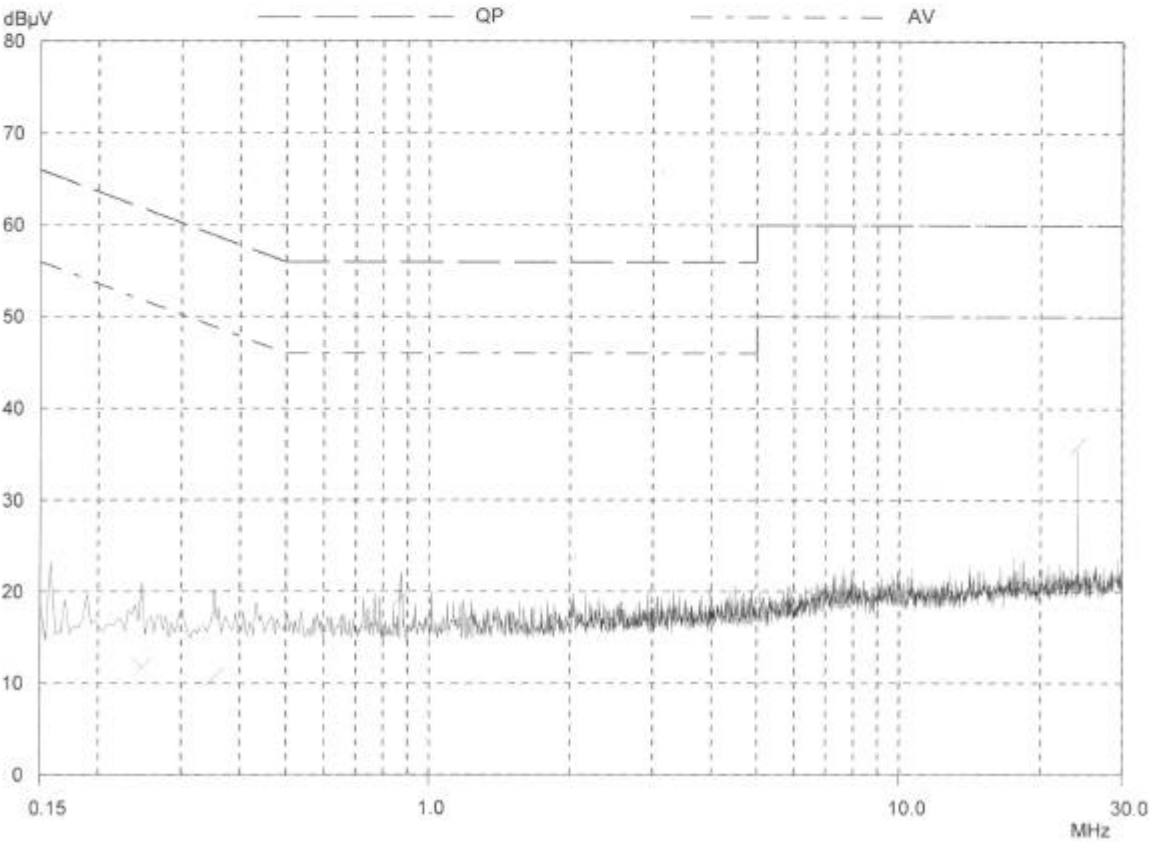
## **Appendix 1 : Plotted Data of Power Line Conducted Emissions**

CONDUCTION EMISSION TEST

Peak Value

EUT: Bluetooth  
Manuf:  
Op Cond: Charge  
Operator:  
Test Spec:  
Comment: N

Final Measurement: Detector: X QP  
Meas Time: 1sec  
Peaks: 8  
Acc Margin: 25 dB



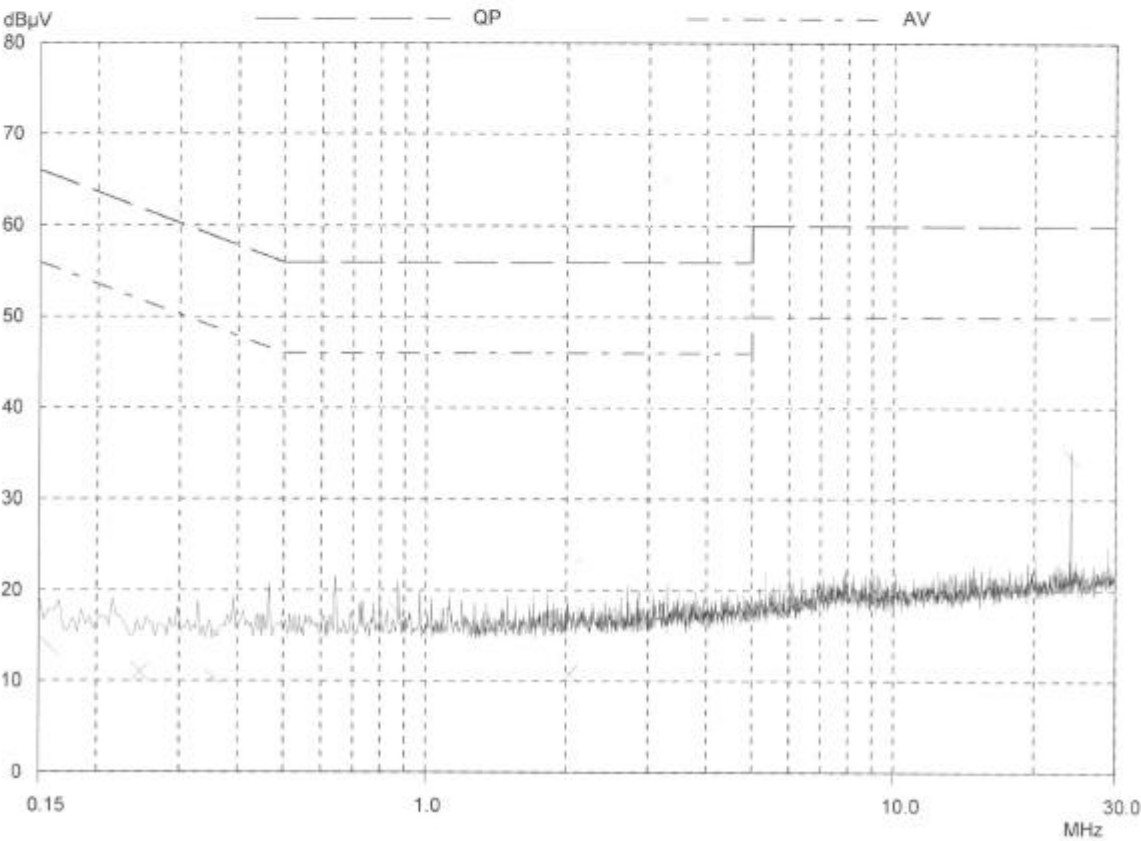


CONDUCTION EMISSION TEST

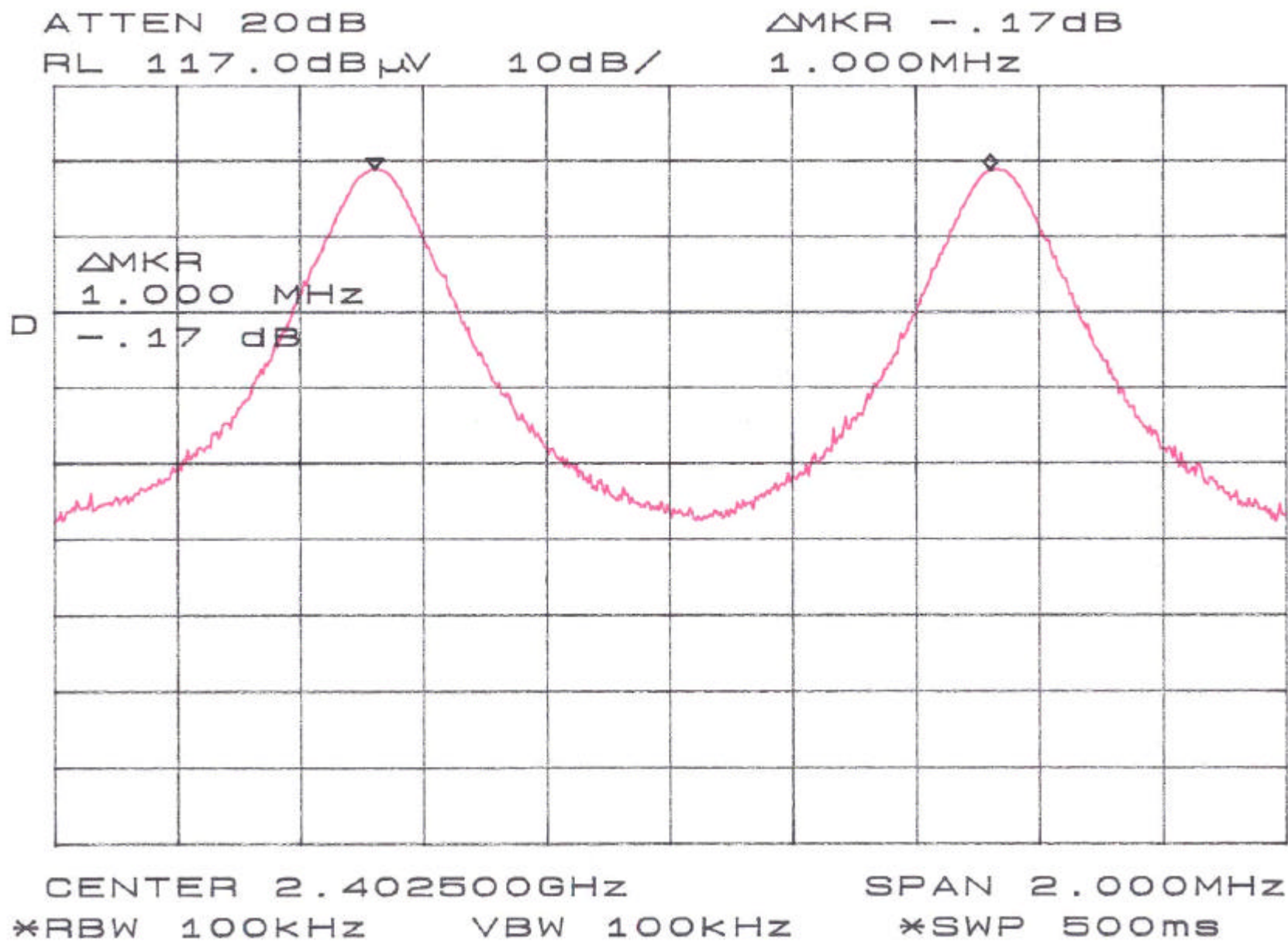
Peak Value

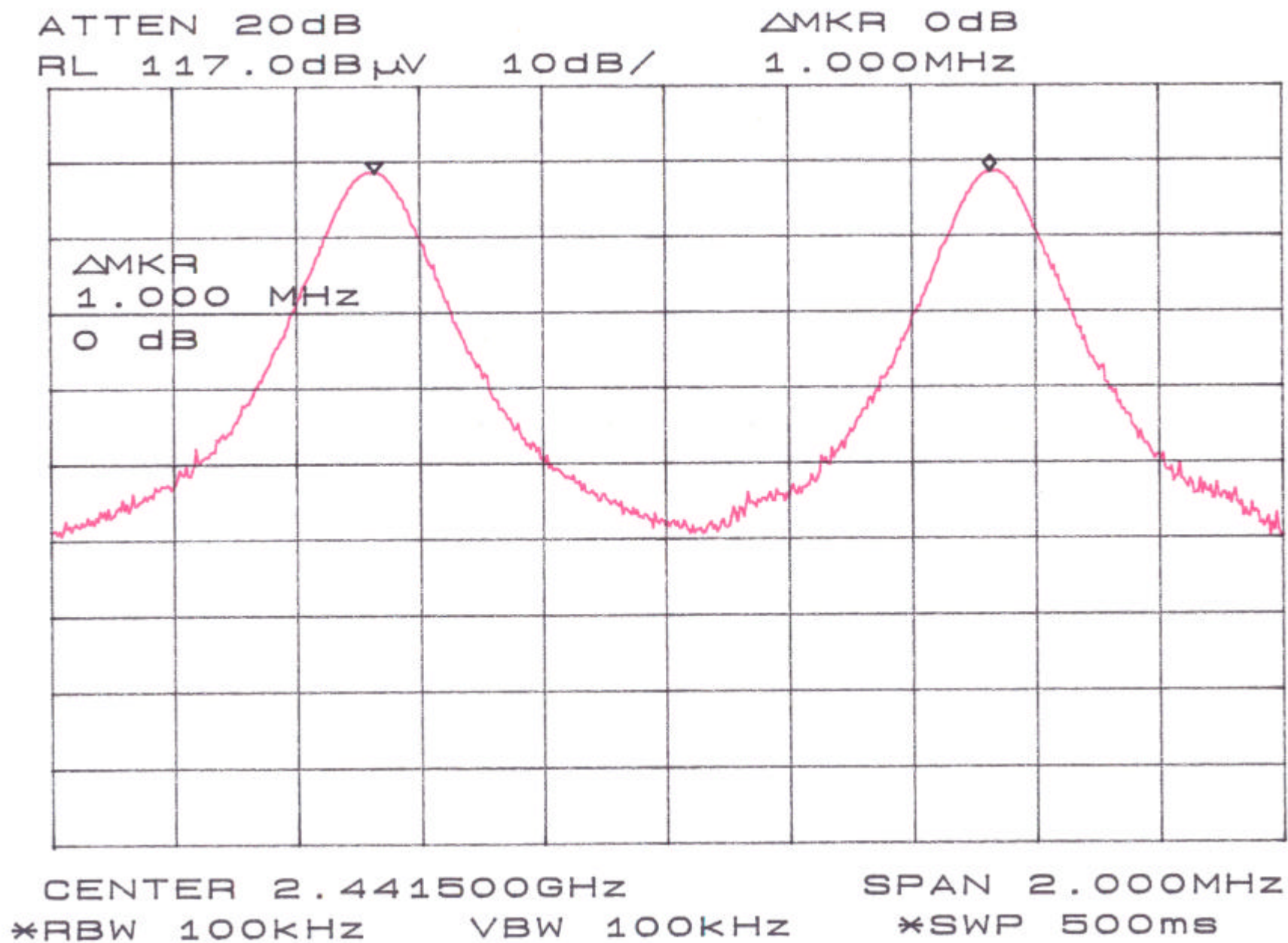
EUT: Bluetooth  
Manuf:  
Op Cond: Charge  
Operator:  
Test Spec:  
Comment: L1

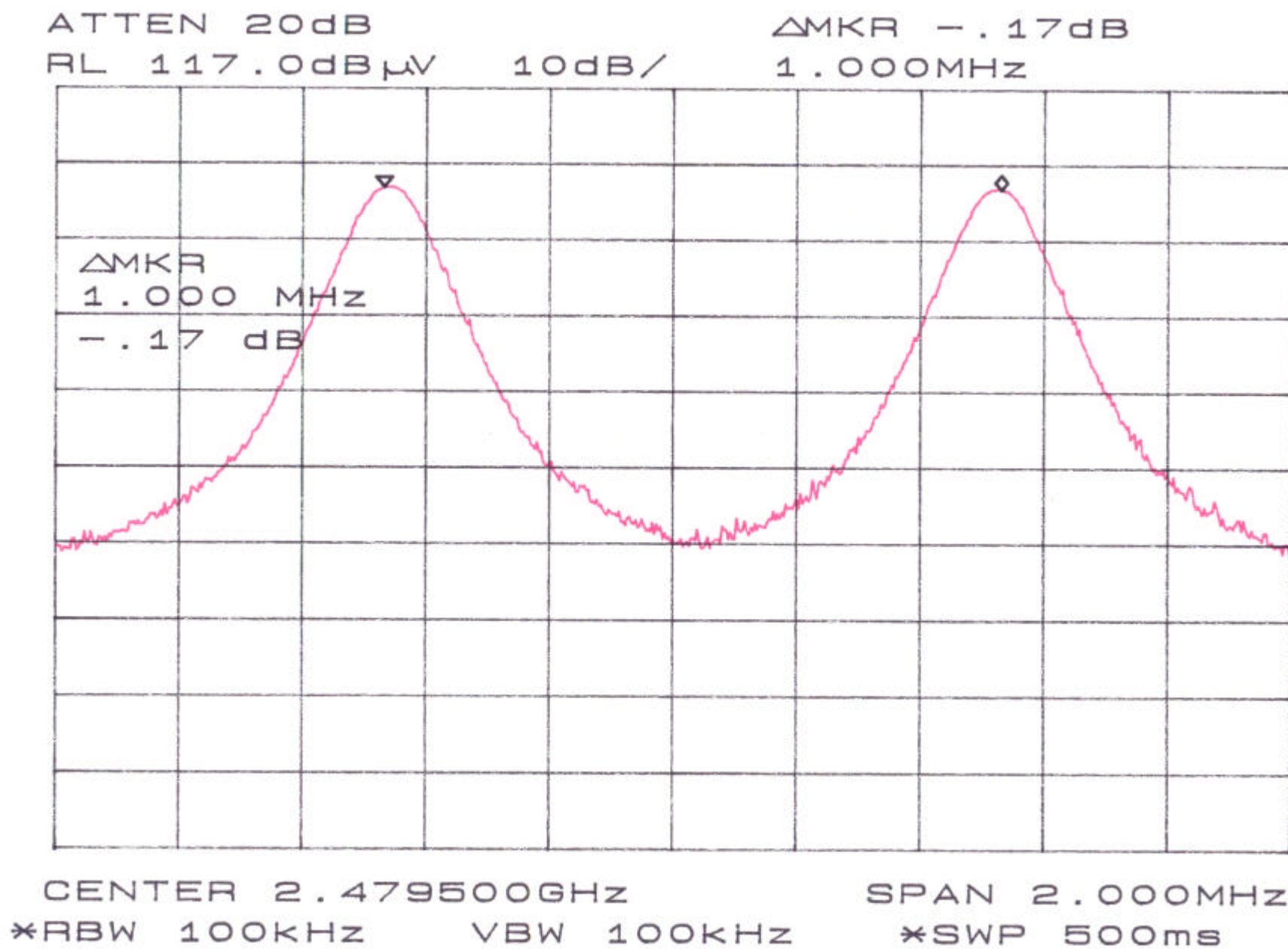
Final Measurement: Detector: X QP  
Meas Time: 1sec  
Peaks: 8  
Acc Margin: 25 dB



## **Appendix 2 : Plotted Data for Separation of Adjacent Channel**

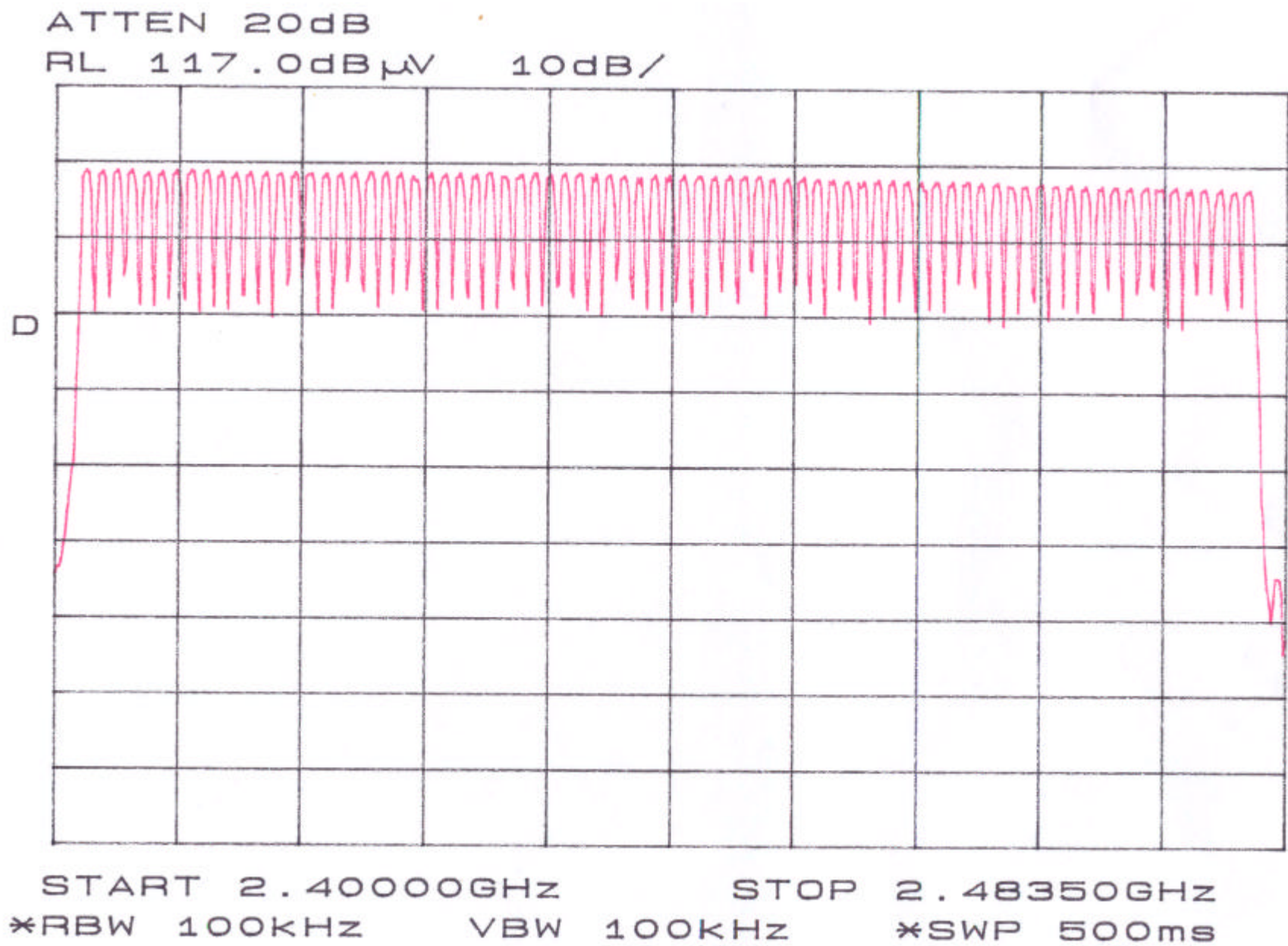






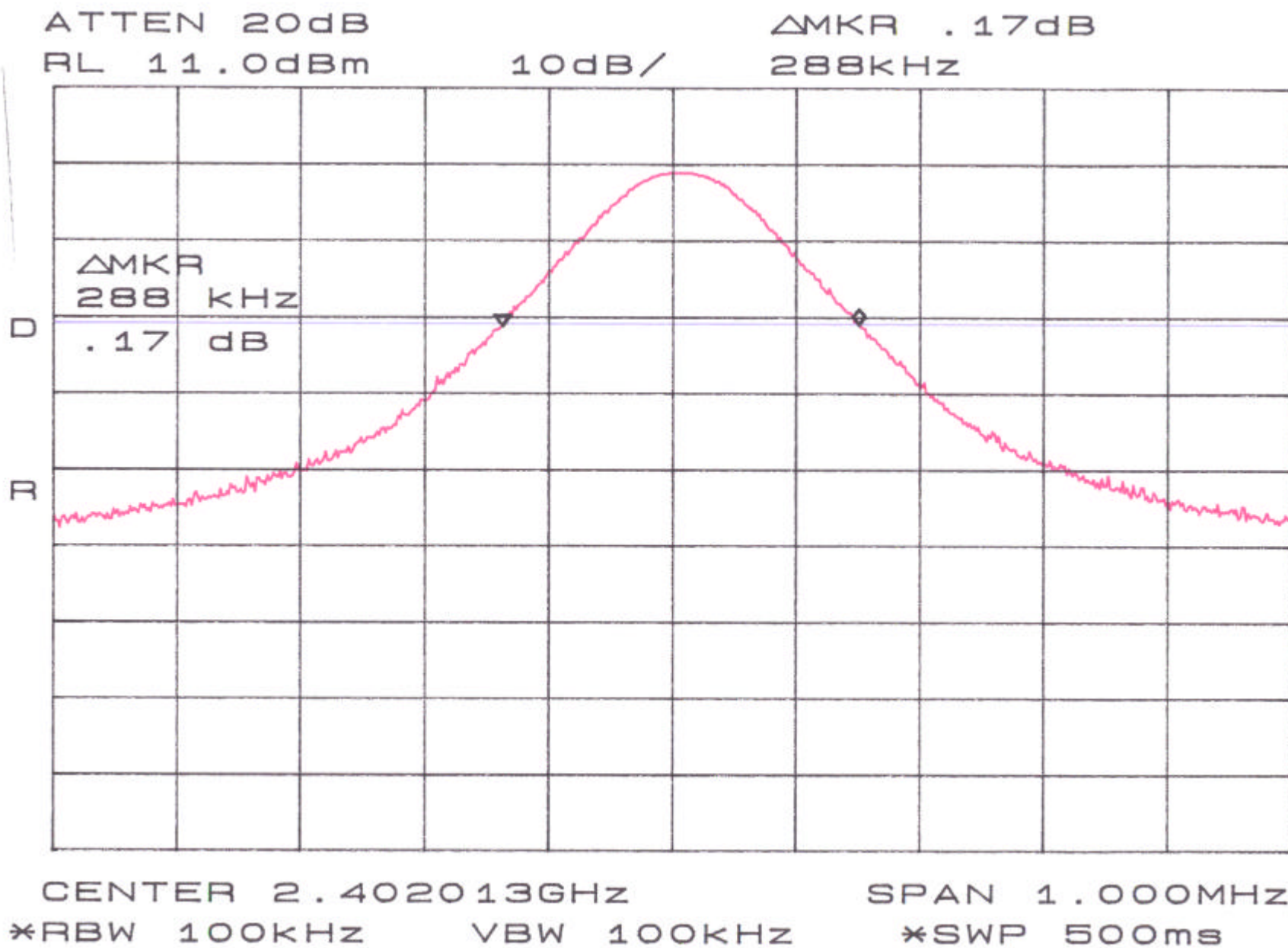
### **Appendix 3 : Plotted Data for Total Used Hopping Frequencies**

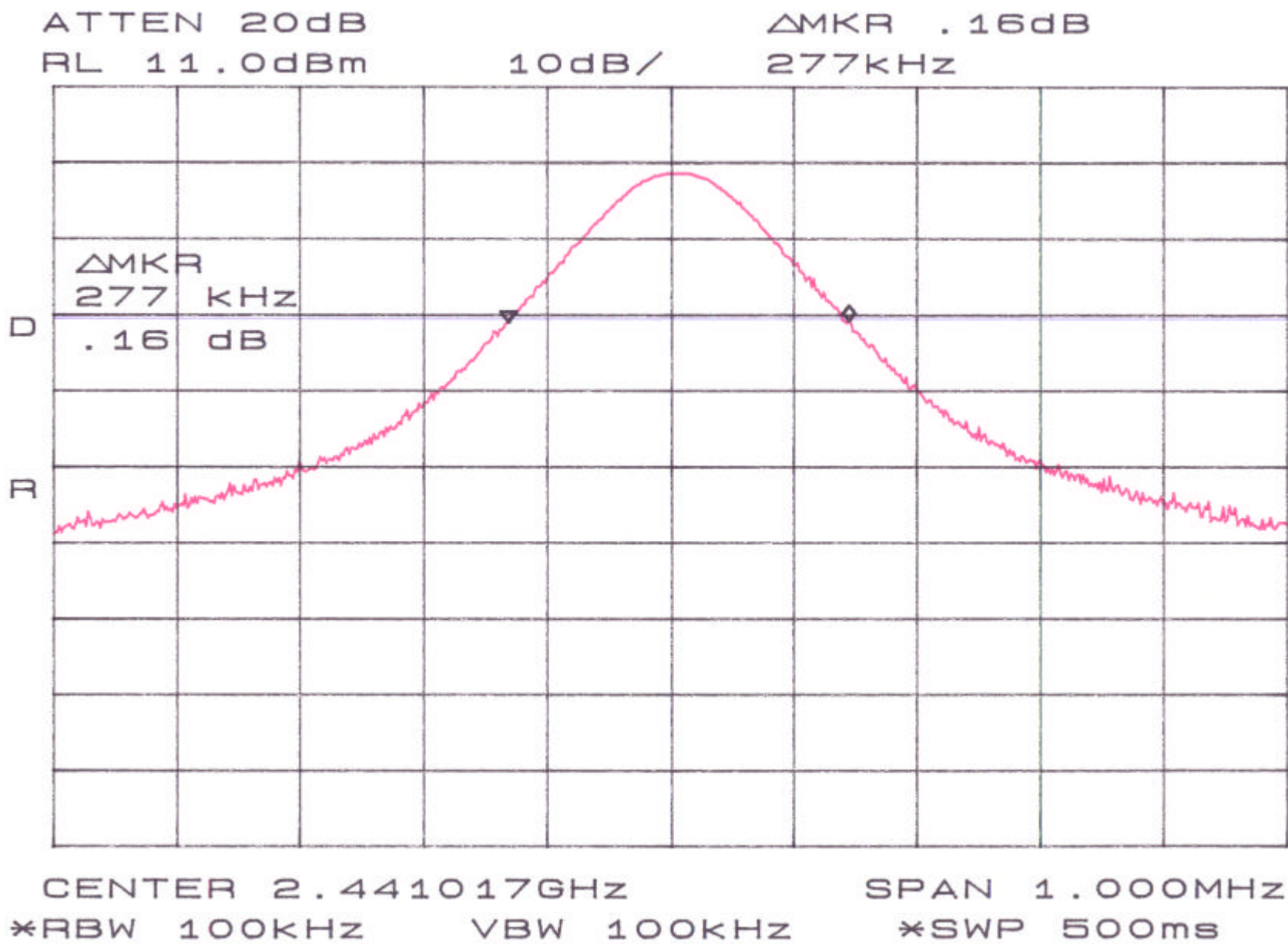


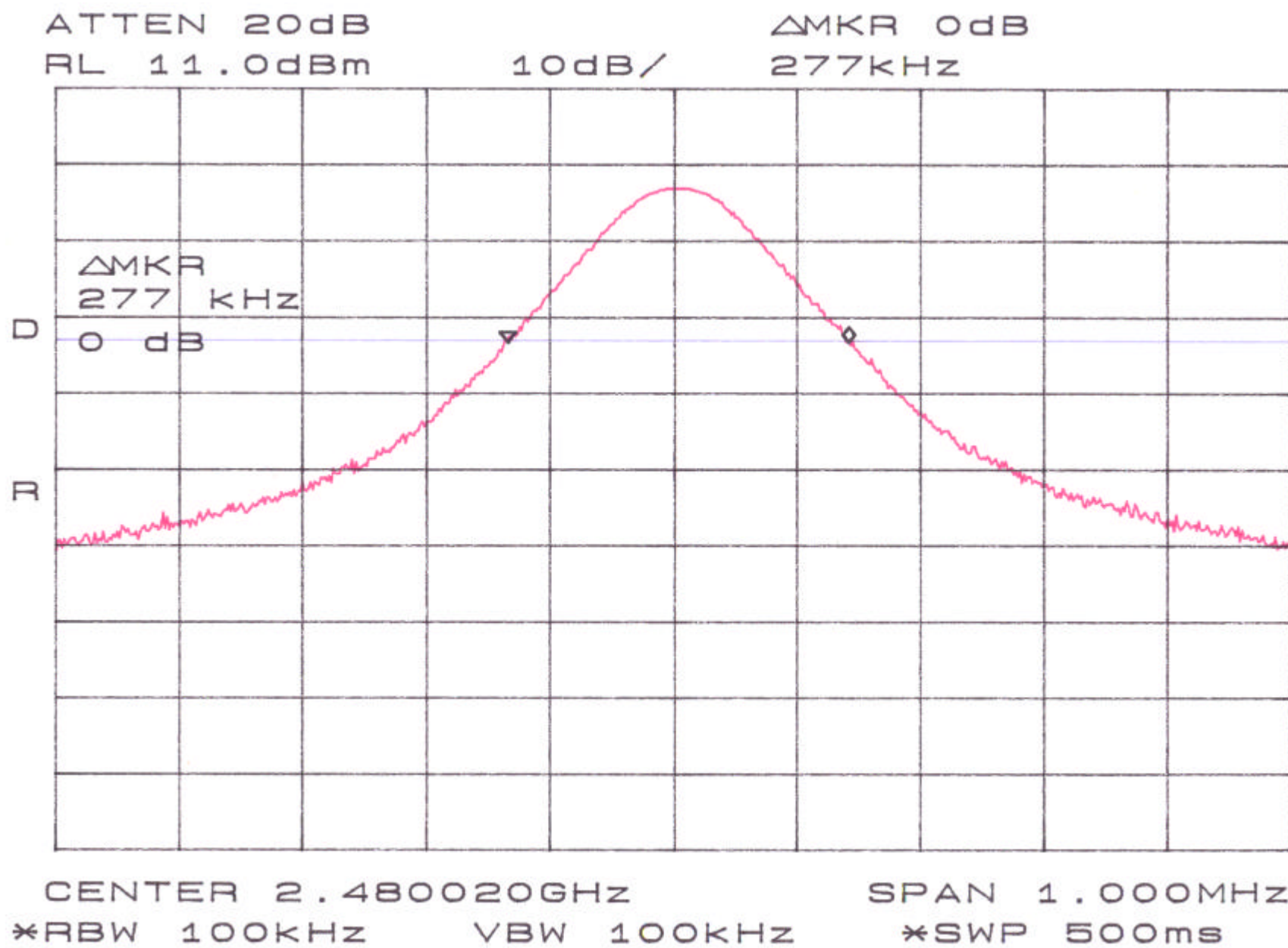


## **Appendix 4 : Plotted Data for Channel Bandwidth**







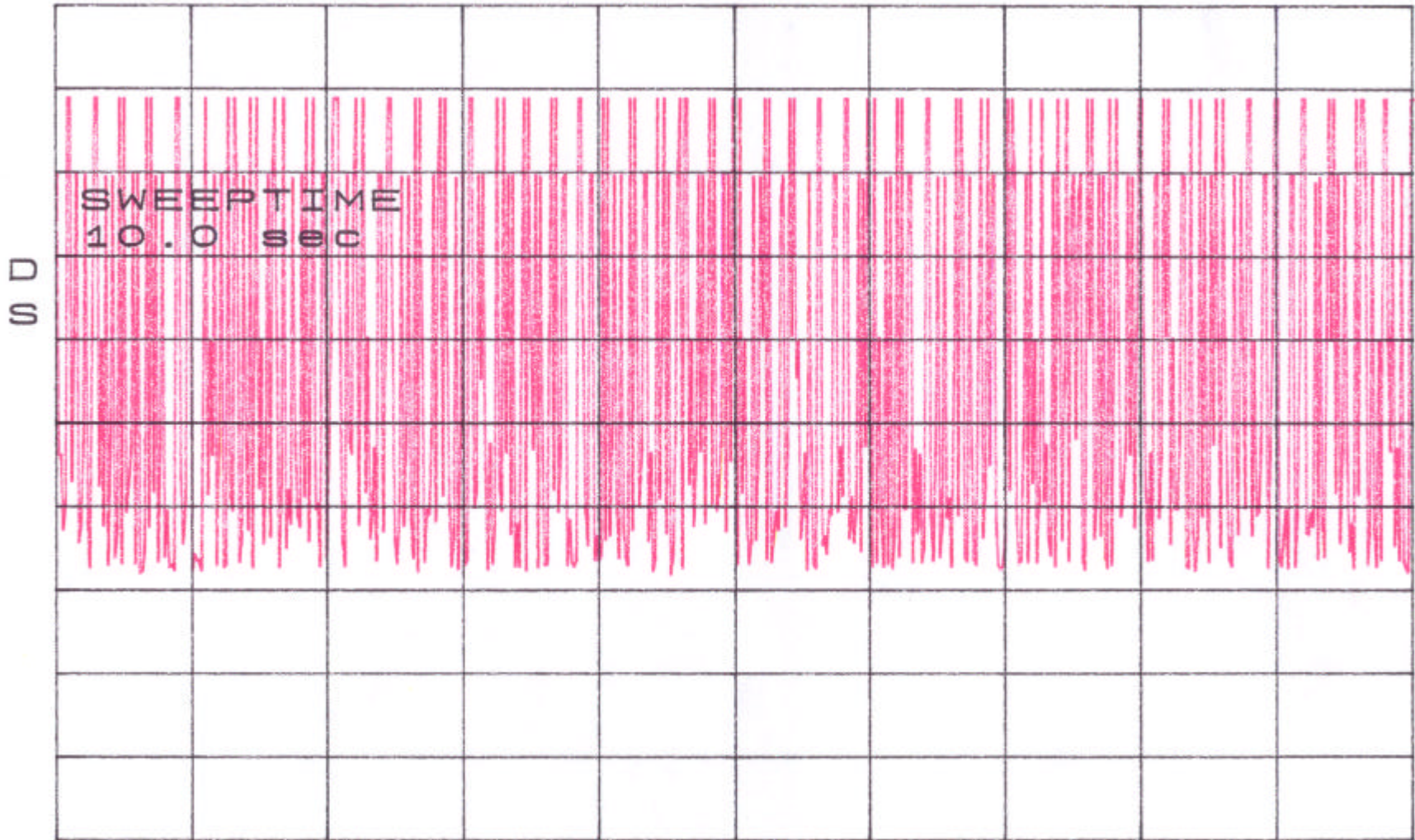


## **Appendix 5 : Plotted Data for Channel Dwell Time**

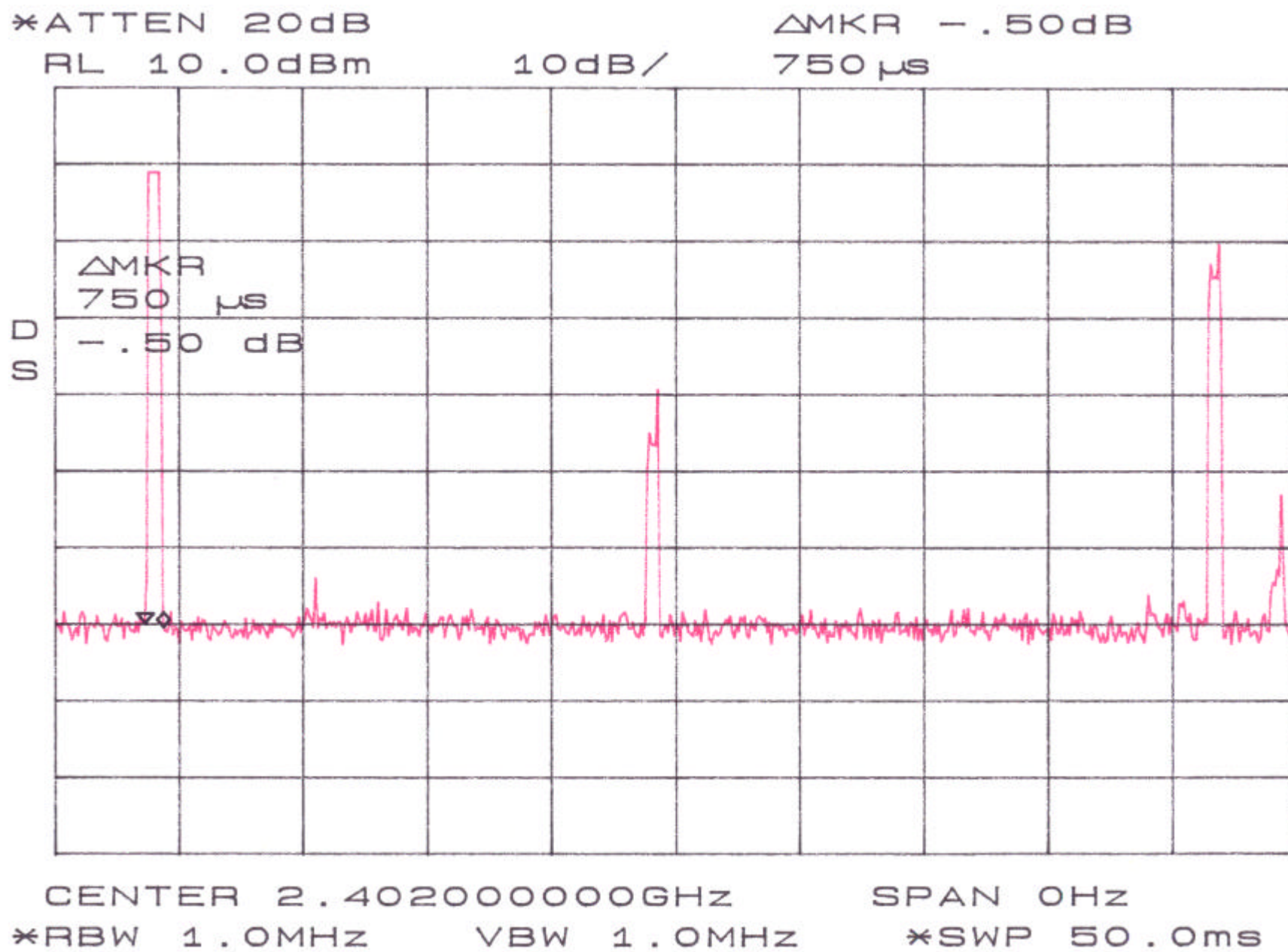


\*ATTEN 20dB  
RL 10.0dBm

10dB/



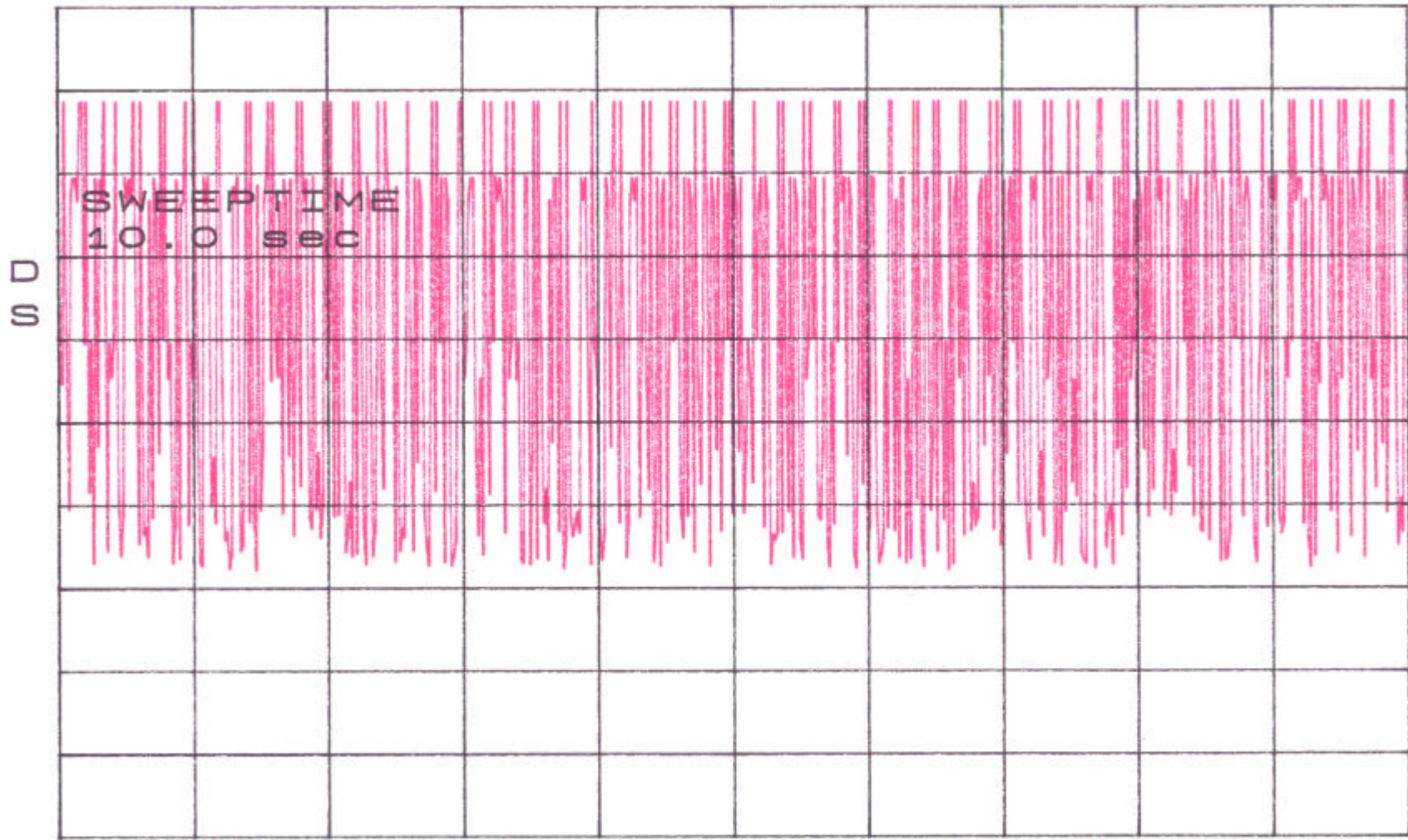
CENTER 2.402000000GHZ SPAN 0Hz  
\*RBW 1.0MHz VBW 1.0MHz \*SWP 10.0sec



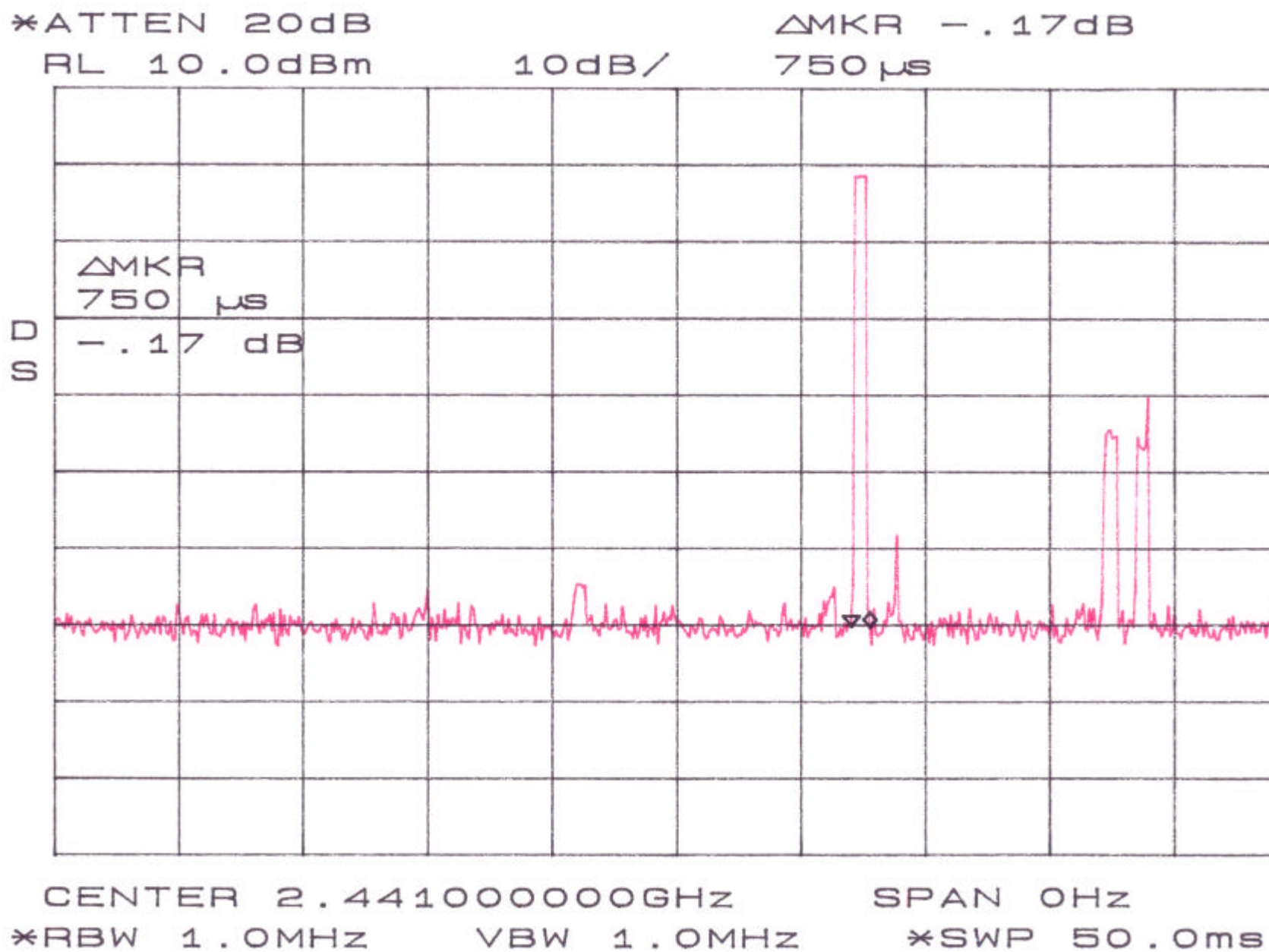


\*ATTEN 20dB  
RL 10.0dBm

10dB/



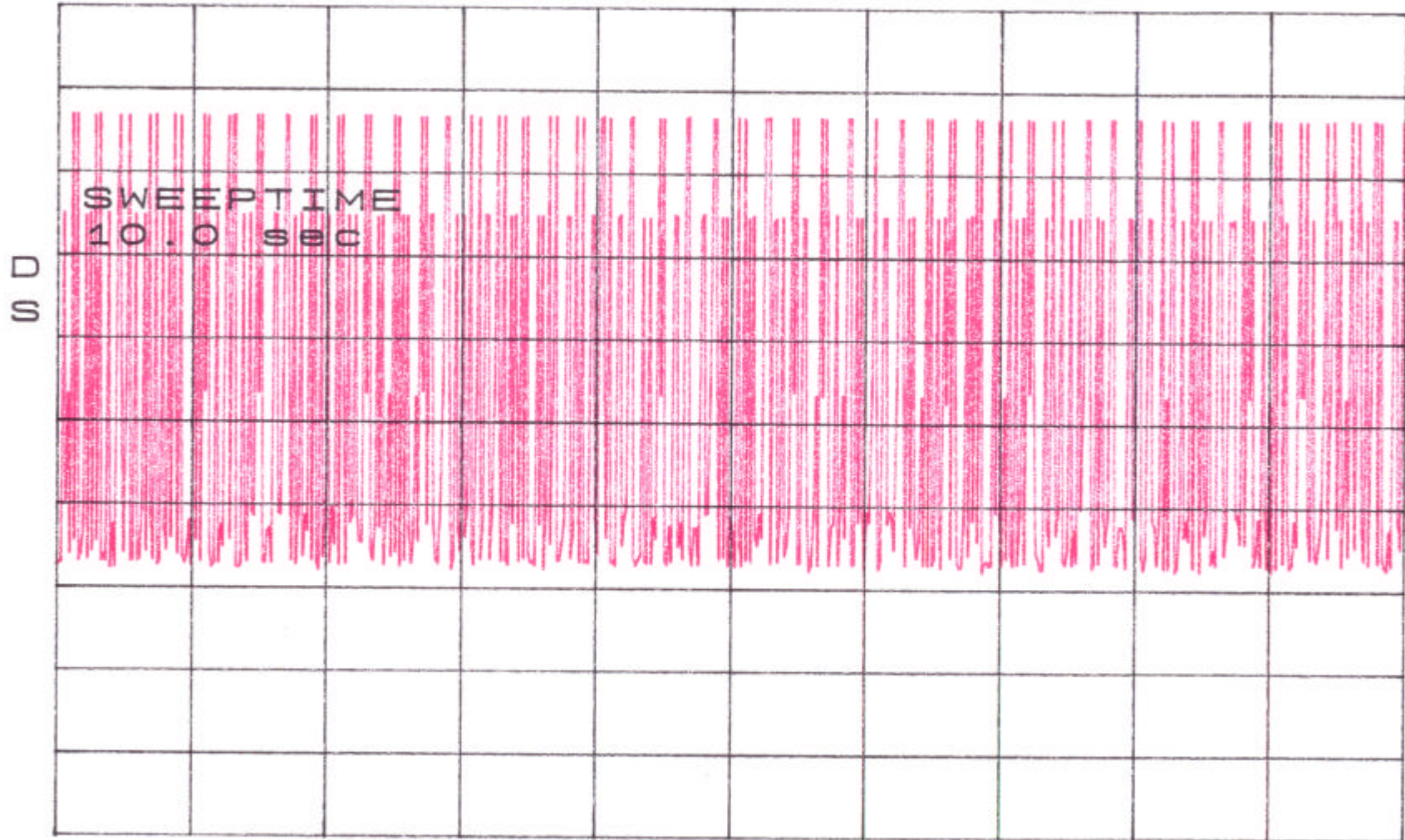
CENTER 2.441000000GHZ SPAN 0HZ  
\*RBW 1.0MHZ VBW 1.0MHZ \*SWP 10.0sec



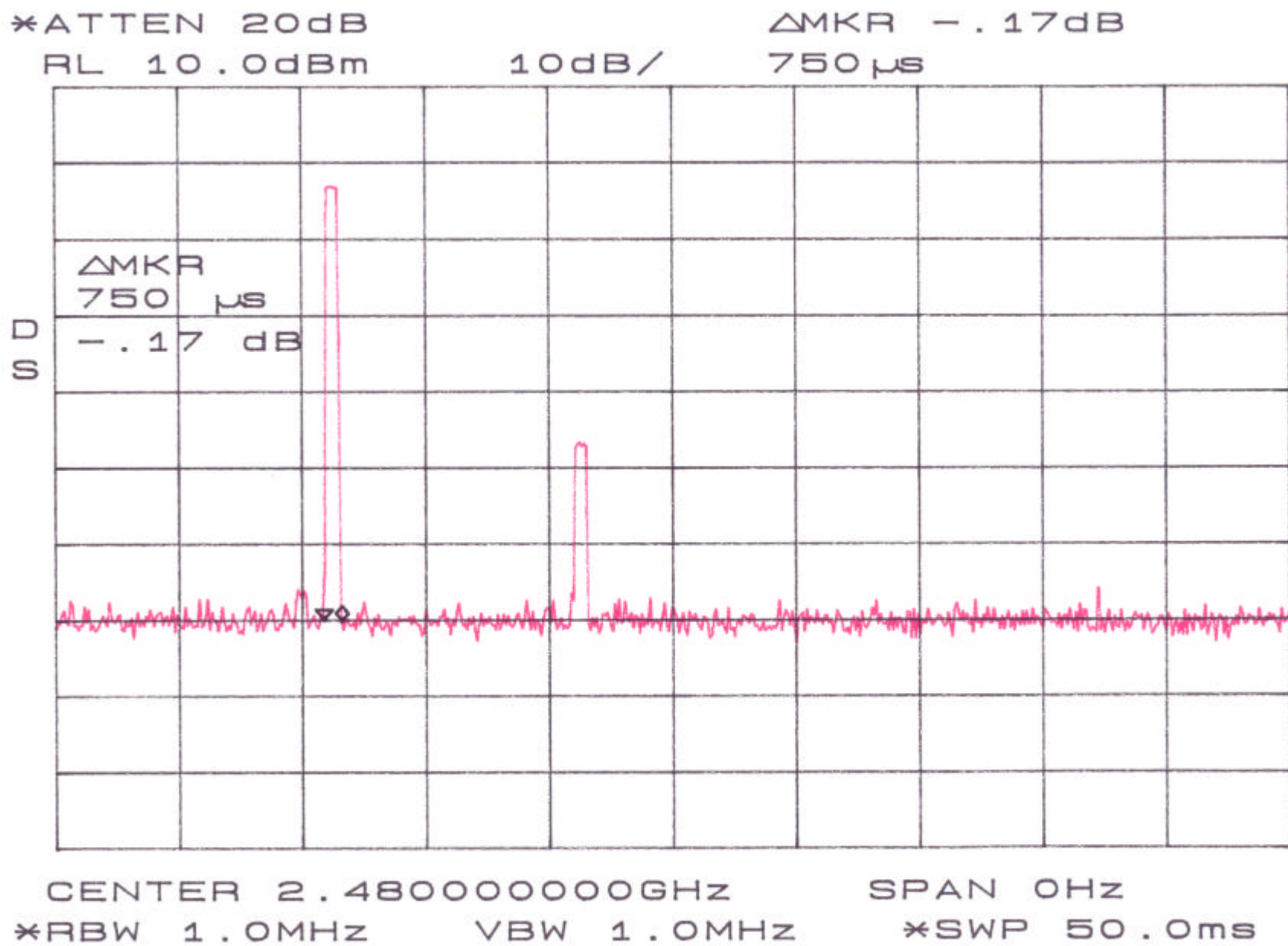


\*ATTEN 20dB  
RL 10.0dBm

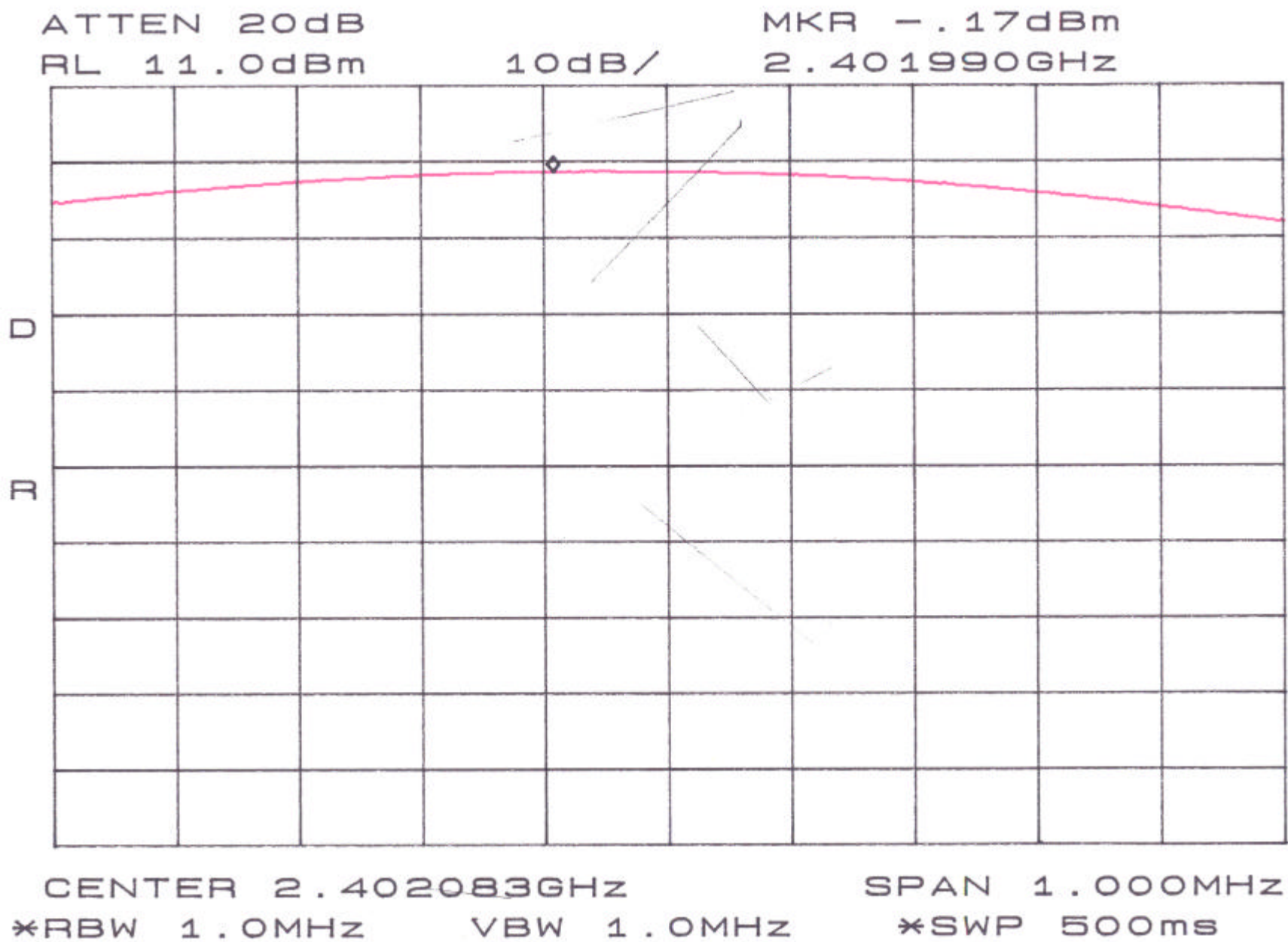
10dB/



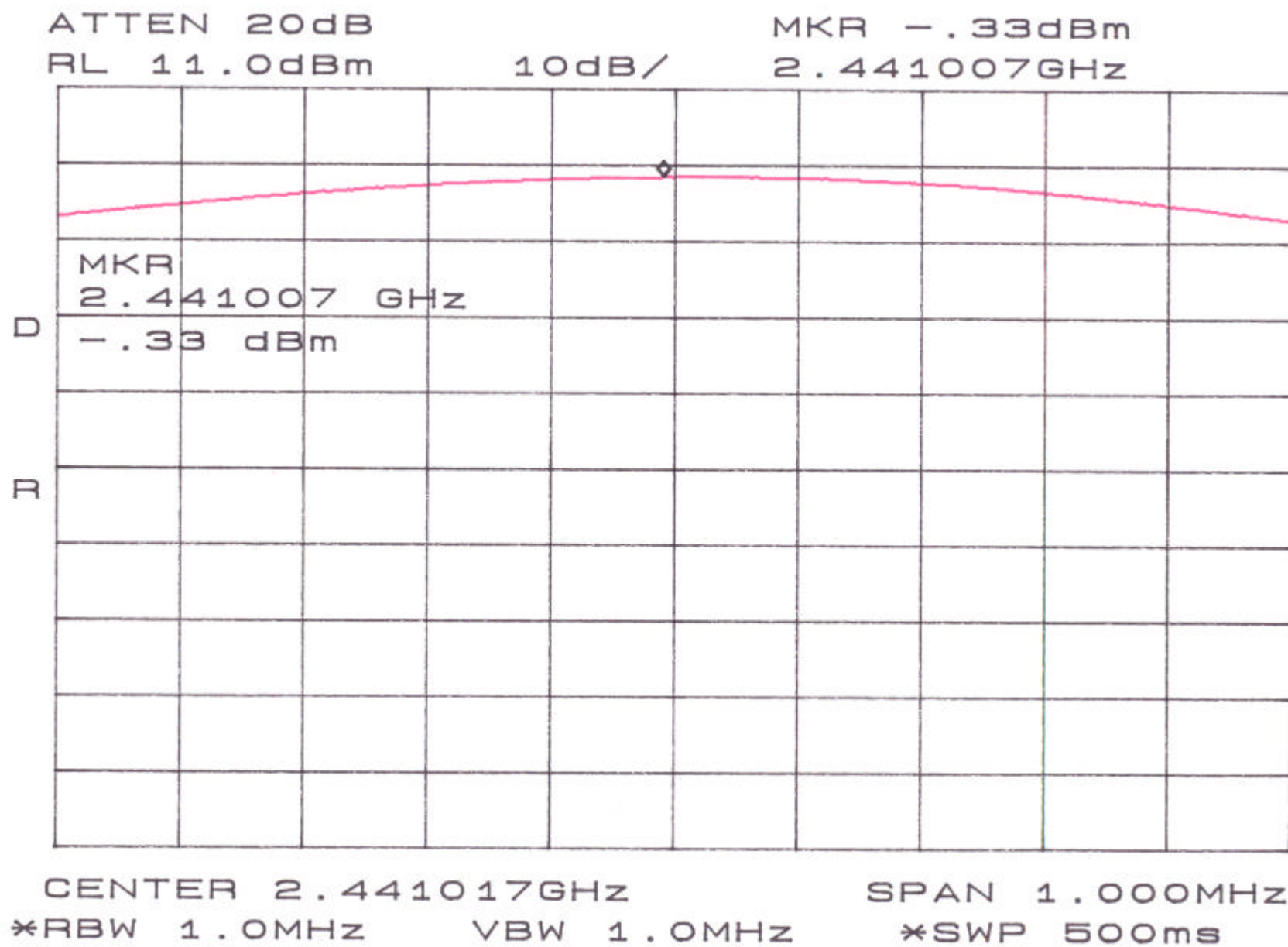
CENTER 2.4800000000GHz SPAN 0Hz  
\*RBW 1.0MHz VBW 1.0MHz \*SWP 10.0sec

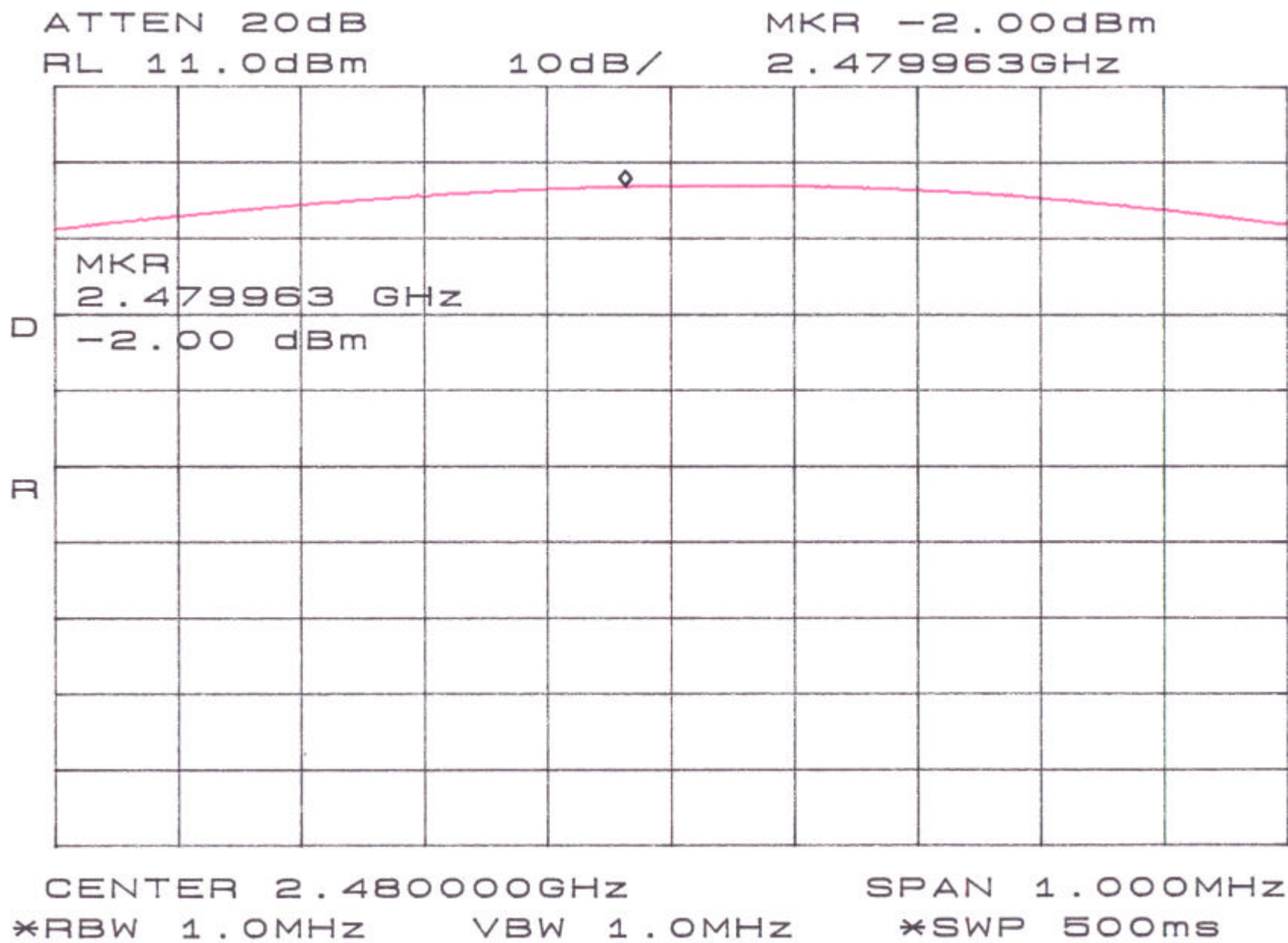


## **Appendix 6 : Plotted Data for Output Peak Power**









## **Appendix 7 : Plotted Data for 100 kHz Bandwidth from Band Edge**

